# Wideband Low Noise Bypass Amplifier TSS-53LNB+

## 50 $\Omega$ 0.5 to 5 GHz

# The Big Deal

- Very wideband, 500 MHz 5 GHz
- Ultra-flat gain, ±0.7 dB from 700 to 2100 MHz
- Low NF over entire frequency band, 1.4 dB
- Internal bypass switching extends useable dynamic range



CASE STYLE: DQ1225

## **Product Overview**

TSS-53LNB+ (RoHS compliant) is an advanced ultra-flat gain Low Noise wideband amplifier fabricated using E-PHEMT technology offering extremely high dynamic range over a broad frequency range. It has integrated switches enabling users to bypass the amplifier during high signal conditions. In addition, the TSS-53LNB+has good input and output return loss over a broad frequency range without the need for external matching components. It is enclosed in a 12-lead 3x3mm MCLP package for good thermal performance.

Feature	Advantages			
Ultra-wideband: 500 MHz – 5 GHz	Ideal for a wide range of receiver applications including military, commercial wireless and instrumentation.			
Very flat gain	Ideal for broadband or multi-band applications. Just one, cost-efficient model required for multiple frequency usage.			
Minimal external matching components required. 15 dB return loss typ.	Minimizes the need for external matching networks, simplifying circuit designs, and enabling the amplifier to operate over multiple bands in a single application circuit.			
High IP3: 48 dBm typ. (bypass mode)	Provides enhanced linearity over broad frequency range under high signal conditions.			
Internal bypass switch feature	Unique design handles low to high signal levels with minimal noise distortion.			
Built-in DC blocking cap at RF-Out port & separate pads for RF-Out & Vdd	Simplifies biasing eliminates need for Bias-Tee at output.			
Compact size: 3 x 3 x 0.9 mm	Saves space in dense system layouts. Low inductance, repeatable transitions, and excellent thermal contact.			

# **Key Features**

# Wideband Low Noise Bypass Amplifier 0.5-5 GHz

### **Product Features**

- Wideband: 0.5-5 GHz
- Built-in Bypass switching
- Low Noise figure: 1.4 dB typ. at 2.0 GHz
- High Gain: 21.7 dB typ. at 2 GHz
- Ultra Flat Gain: 0.7 dB from 0.7 to 2.1 GHz
- P1dB: +21 dBm typ. at 2.0 GHz
- Minimal matching components
- Specified over full band operation

## **Typical Applications**

- Wireless Base Station Systems
- Test and Measurement Systems
- Multi-Band Receivers

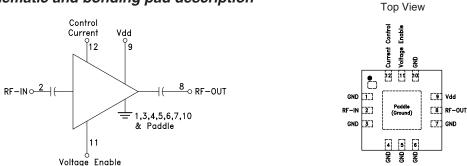


+RoHS Compliant The +Suffix identifies RoHS Compliance. See our web site for RoHS Compliance methodologies and qualifications

## **General Description**

TSS-53LNB+ (RoHS compliant) is an advanced ultra-flat gain Low Noise wideband amplifier fabricated using E-PHEMT technology offering extremely high dynamic range over a broad frequency range. It has integrated switches enabling users to bypass the amplifier during high signal conditions. In addition, the TSS-53LNB+has good input and output return loss over a broad frequency range without the need for external matching components. It is enclosed in a 12-lead 3x3mm MCLP package for good thermal performance.

## simplified schematic and bonding pad description



Function	Pad Number	Description (See Figure 2)		
RF-IN	2	RF-Input pad. Connect to Ground Via L1. Add a DC blocking cap in series of appropri- ate value if required.		
RF-OUT	8 RF-Output pad. No external DC blocking cap required.			
Current Control	12	Control Current pad, voltage level on this pad sets the ldd. Connect to pad 11 via 3.92 $k\Omega$ resistor.		
Voltage Enable	11	Voltage Enable Pad. Voltage level on this pad determines Amplifier is ON or bypassed.		
Vdd	9	Supply Voltage Pad. Connect to Vdd via L2.		
Ground	1,3,4,5,6,7,10 Paddle	Connect to ground. Use via holes as shown in "Suggested Layout for PCB Design" to reduce ground path inductance for best performance.		



# TSS-53LNB+

## Electrical Specifications<sup>(1)</sup> at 25°C, Zo=50 $\Omega$ and vdd=5V, unless otherwise noted

Devementer		A	mplifier-	ON	Amplifier-Bypass	Unite
Parameter	Condition (GHz)	Min. Typ. Max.		Тур.	Units	
Frequency Range		0.5		5.0		GHz
	0.5		1.3		0.7	
	1.0		1.2		0.9	
	2.0		1.4		0.9	
Noise Figure	3.0		1.4		1.0	dB
	4.0		1.6		1.4	
	5.0		1.7		1.1	
	0.5	_	22.8	_	-0.7	
	1.0	_	22.7	_	-0.7	
0-1-	2.0	19.5	21.7	23.9	-0.9	-10
Gain	3.0	_	20.5	_	-1.0	dB
	4.0	_	19.5	_	-0.9	
	5.0	_	18.7	—	-1.0	
Gain Flatness	0.7 - 2.1		±0.7		±0.14	dB
	0.5	_	16.0		25.8	
	1.0	—	15.1		18.5	
Input Return Loss	2.0	10.5	14.5		12.3	dB
Input Heldin Loss	3.0	_	13.1		11.1	UD UD
	4.0	_	14.5		14.5	
	5.0		16.9		16.9	
	0.5		11.8		22.8	
	1.0		12.5		17.1	
Output Return Loss	2.0		17.0		12.6	dB
Ouipui Heium Loss	3.0		14.1		11.7	uв
	4.0		10.7		14.0	
	5.0		10.0		11.9	
	0.5		21.1		32.0	
	1.0		21.0		—	
Output Power @1dB compression AMP-ON (2)	2.0		20.6		33.0	dBm
Input Power @1dB compression AMP-Bypass (2)	3.0		20.1		_	UDIT
	4.0		20.2		_	
	5.0		19.2		27.0	
	0.5		35.1		48.0	
	1.0		34.5		48.4	
Output IP3	2.0		33.9		45.2	
Output IF3	3.0		32.7		42.9	
	4.0		33.4		42.0	
	5.0		30.9		40.8	
Device Operating Voltage (Vdd)		4.8	5.0	5.2	4.8-5.2 (5.0 typ.)	V
Device Operating Current (Id)			82	105	2	mA
Enable Voltage (Ve)			5.0		0	V
Enable Control Current (le)			2.0		0	mA
DC Current (Id) Variation Vs. Temperature (3)			-19			µA/°C
DC Current (Id) Variation Vs. Voltage			0.008		—	mA/mV
Thermal Resistance, junction-to-ground lead			60		-	°C/W

<sup>(1)</sup> Measured on Mini-Circuits Characterization test board TB-780+. See Characterization Test Circuit (Fig. 1)

<sup>(2)</sup> Current increases at P1dB
 <sup>(3)</sup> (Current at 85°C - Current at -45°C)/130)

## Absolute Maximum Ratings<sup>(5)</sup>

Parameter		Ratings		
Operating Temperature (ground lead)		-40°C to 85°C		
Storage Temperature		-65°C to 150°C		
Total Power Dissipation		0.7 W		
	Amplifier-ON	8 dBm (continuous), 19 dBm (5 min max.)		
Input Power	Amplifier Bypass	16 dBm (continuous), 29 dBm (5 min max.)		
DC Voltage Vdd		7.0 V		
DC Voltage Enable		7.0 V		
Max. Voltage on pad 8		15 V		

<sup>(5)</sup> Permanent damage may occur if any of these limits are exceeded.

Electrical maximum ratings are not intended for continuous normal operation.

### ous normal operation. Mini-Circuits

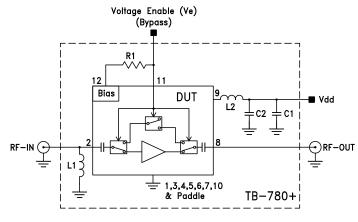
## Enable Voltage (Ve) Fig. 1

	Min.	Тур.	Max.	Units
Amplifier-ON	4.5	5.0	5.5	V
Amplifier-Bypass	0	_	0.5	V



Parameter			Тур.	Max.	Units	
Amplifier ON to Dunges	OFF TIME (50% Control to 10% RF)	_	50	—	ns	
Amplifier ON to Bypass	FALL TIME (90 to 10% RF)	_	12	_		
Amerikian Dumana ta ON	ON TIME (50% Control to 90% RF)	_	740	_		
Amplifier Bypass to ON	RISE TIME (10% to 90% RF)	_	240	_	ns	
Control Voltage Leakage		_	65	_	mV	

## **Characterization Test Circuit**



Component	Size	Value	Units
L1	0402	47	nH
L2	0402	56	nH
C1	0402	0.1	μF
C2	0402	10	pF
R1	0402	3.92	KΩ

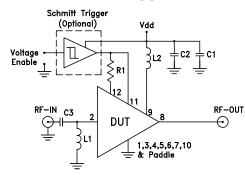
Fig 1. Block diagram of Test Circuit used for characterization. (DUT soldered on Mini-Circuits Characterization test board TB-780+) Gain, Return loss, Output power at 1dB compression (P1 dB), output IP3 (OIP3) and noise figure measured using Agilent's N5242A PNA-X microwave network analyzer.

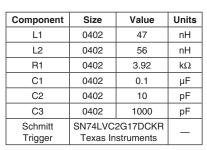
#### Conditions:

- 1. Gain and Return loss: Pin= -25dBm
- 2. Output IP3 (OIP3): Two tones, spaced 1 MHz apart, 0 dBm/tone at output.
- 3. Switching Time: Pin=-25 dBm at 500 MHz. Venable=4.5, 5.0, 5.5V at 10 kHz.

Vd=4.75, 5.0 and 5.5V.

## **Recommended Application Circuit**





## **Product Marking**

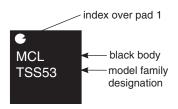


Fig 2. Recommended Application Circuit.